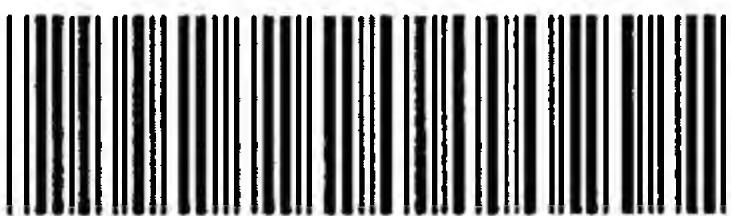


Search Notes



Application/Control No.

10/709,925

Examiner

Junghwa M. Im

**Applicant(s)/Patent under
Reexamination**

KUNG ET AL.

Art Unit

2811

SEARCHED

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)